

Test Report

Report No. : MTi250324005-0102E1

Date of issue : 2025-04-02

Applicant : Hong Kong Etech Groups Ltd.

Product : True Wireless Earbuds with Charging Case

Model(s) : EBB2-240090A, 4SP036A9YZ

FCC ID : 2A3ZO-240090A

Shenzhen Microtest Co., Ltd.



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Test Result Certific	cation		
Applicant	Hong Kong	g Etech Groups Ltd.	
Applicant Address 16/F, Block C,2nd Phase of Central Avenue, Haihong Industrial Xixiang, Baoan, Shenzhen, China			
Manufacturer	Hong Kong	g Etech Groups Ltd.	
Manufacturer Address		C,2nd Phase of Central Avenue aoan, Shenzhen, China	e, Haihong Industrial Area,
Product description	n		(A) PHE
Product name	True Wirele	ess Earbuds with Charging Case	
Trademark	N/A		
Model name	EBB2-2400	090A	
Series Model(s)	4SP036A9	YZ MICI	
Standards	47 CFR Pa	art 15.247	
Test Method	KDB 55807 ANSI C63.	74 D01 15.247 Meas Guidance v 10-2020	v05r02
Testing Informatio	n		Mici
Date of test	2025-03-26	6 to 2025-04-01	
Test result	Pass		
Prepared by:		Maleah Deng	Modern Davy
Reviewed I	oy:	David Lee	Modern Dowy Dowid. Cee Lewis Lian
Approved I	by:	Lewis Lian	lewis lion



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1 General Description

1.1 Description of the EUT

Product name:	True Wireless Earbuds with Charging Case
Model name:	EBB2-240090A
Series Model(s):	4SP036A9YZ
Model difference:	All the models are the same circuit and module, except the model name.
Electrical rating:	Input: DC 5V 300mAh Battery: Earbuds: DC 3.7V 30mAh; Charging box: DC 3.7V 300mAh
Accessories:	N/A
Hardware version:	V1.0
Software version:	V1.0
Test sample(s) number:	MTi250324005-01-R001
RF specification	- I Ole
Bluetooth version:	V5.3
Operating frequency range:	2402-2480MHz
Channel number:	79
Modulation type:	GFSK, π/4-DQPSK, 8DPSK
Antenna(s) type:	PCB Antenna
Antenna(s) gain:	-0.68dBi
	·

1.2 Description of test modes

No.	Emission test modes
Mode1	TX-GFSK
Mode2	TX-π/4-DQPSK
Mode3	TX-8DPSK

1.2.1 Operation channel list

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
0	2402	20	2422	40	2442	60	2462
NI DI	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466



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5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461	-	-

Test Channel List

Lowest Channel (LCH)	Middle Channel (MCH)	Highest Channel (HCH)
(MHz)	(MHz)	(MHz)
2402	2441	

Note: The test software provided by manufacturer is used to control EUT for working in engineering mode, that enables selectable channel, and capable of continuous transmitting mode.

Test Software:

For power setting, refer to below table.

Test Software:		BT_Tool	Z.
Mode	2402MHz	2441MHz	2480MHz
GFSK	2	2	MiCl 2
π/4-DQPSK	2	2	2
8DPSK	2	2	2



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1.3 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C ~ 35°C	
Humidity:	20% RH ~ 75% RH	
Atmospheric pressure:	98 kPa ~ 101 kPa	

1.4 Description of support units

Support equipment list						
Description	Model	Serial No.	Manufacturer			
/		/	NCIO CONTRACTOR			
Support cable list						
Description	Length (m)	From	То			
(017	1	/	1			

1.5 Measurement uncertainty

Measurement	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	±3.1dB
Occupied channel bandwidth	±3 %
RF output power, conducted	±1 dB
Time	±1 %
Unwanted Emissions, conducted	±1 dB
Radiated spurious emissions (above 1GHz)	±5.3dB
Radiated spurious emissions (9kHz~30MHz)	±4.3dB
Radiated spurious emissions (30MHz~1GHz)	±4.7dB
Temperature	±1 °C
Humidity	± 5 %

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



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2 Summary of Test Result

No.	Item	Standard	Requirement	Result
1	Antenna requirement	47 CFR Part 15.247	47 CFR 15.203	Pass
2	Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	N/A
3	20dB Bandwidth	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
4	Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(1)	Pass
5	Channel Separation	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
6	Number of Hopping Frequencies	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
7	Dwell Time	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
8	RF conducted spurious emissions and band edge measurement	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
9	Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
10	Radiated emissions (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
11	Radiated emissions (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass

Note1: Since the EUT is DC powered, therefore AC power line conducted emissions test is not required.



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3 Test Facilities and accreditations

3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.
Test site location:	101, No.7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Telephone:	(86-755)88850135
Fax:	(86-755)88850136
CNAS Registration No.:	CNAS L5868
FCC Registration No.:	448573
IC Registration No.:	21760
CABID:	CN0093
Mil.	Microtest

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4 List of test equipment

4	List of test equipm					
No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due
2.0	OLE	Conducted Emiss	ion at AC power	line		
1	EMI Test Receiver	Rohde&schwarz	ESCI3	101368	2025-03- 13	2026-03- 12
2	Artificial mains network	Schwarzbeck	NSLK 8127	183	2025-03- 18	2026-03- 17
3	Artificial Mains Network	Rohde & Schwarz	ESH2-Z5	100263	2025-03- 18	2026-03- 17
		Number of Hop Dwe nissions in non-res	Separation ping Frequencie II Time	es		YOU
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2025-03- 18	2026-03- 17
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB400512 40	2025-03- 14	2026-03- 13
3	PXA Signal Analyzer	Agilent	N9030A	MY513502 96	2025-03- 14	2026-03- 13
4	Synthesized Sweeper	Agilent	83752A	3610A019 57	2025-03- 18	2026-03- 17
5	MXA Signal Analyzer	Agilent	N9020A	MY501434 83	2025-03- 18	2026-03- 17
6	RF Control Unit	Tonscend	JS0806-1	19D80601 52	2025-03- 18	2026-03- 17
7	Band Reject Filter Group	Tonscend	Tonscend JS0806-F 19D8		2025-03- 18	2026-03- 17
8	ESG Vector Signal Generator	Agilent	N5182A	MY501437 62	2025-03- 14	2026-03- 13
9	DC Power Supply	Agilent	E3632A	MY400276 95	2025-03- 18	2026-03- 17
All	Er	Band edge emi	ssions (Radiated	,		
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2025-03- 14	2026-03- 13
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-06- 17	2025-06- 16
3	Amplifier	Agilent	8449B	3008A0112 0	2025-03- 18	2026-03- 17
4	MXA signal analyzer	MXA signal analyzer Agilent N9020A		MY544408 59	2025-03- 14	2026-03- 13
5	PXA Signal Analyzer	PXA Signal Analyzer Agilent N9030		MY513502 96	2025-03- 14	2026-03- 13
6	Horn antenna	Schwarzbeck	BBHA 9170	00987	2023-06- 17	2025-06- 16
7	Pre-amplifier	Space-Dtronics	EWLAN1840 G	210405001	2025-03- 19	2026-03- 18
1	Er	missions in frequen		1GHz)	•	
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2025-03- 14	2026-03- 13
2	TRILOG Broadband Antenna	schwarabeck	VULB 9163	9163-1338	2023-06-11	2025-06- 10



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No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due
3	Active Loop Antenna	Schwarzbeck	FMZB 1519 B	00066	2024-03- 23	2026-03- 22
4	Amplifier	Hewlett-Packard	8447F	3113A0618 4	2025-03- 18	2026-03- 17
			"est			
		n'C				
					0.0	

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5 Evaluation Results (Evaluation)

5.1 Antenna requirement

ates.	Refer to 47 CFR Part 15.203, an intentional radiator shall be designed
. ~	to ensure that no antenna other than that furnished by the responsible
Test Requirement:	party shall be used with the device. The use of a permanently attached
rest Requirement.	antenna or of an antenna that uses a unique coupling to the intentional
)	radiator shall be considered sufficient to comply with the provisions of
	this section.

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5.1.1 Conclusion:

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The antenna of the EUT is permanently attached.

The EUT complies with the requirement of FCC PART 15.203.



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6 Radio Spectrum Matter Test Results (RF)

6.1 20dB Bandwidth

6.1 20dB Bandwid	in Control of the Con
Test Requirement:	47 CFR 15.247(a)(1)
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	ANSI C63.10-2020, section 7.8.6, For occupied bandwidth measurements, use the procedure in 6.9.3. Frequency hopping shall be disabled for this test. KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission. The following procedure shall be used for measuring 99% power bandwidth: a) The instrument center frequency is set to the nominal EUT channel center frequency. The frequency span for the spectrum analyzer shall be between 1.5 times and 5.0 times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW, and VBW shall be at least three times the RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the
Microtest	signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.6.2. d) Step a) through step c) might require iteration to adjust within the specified range. e) Video averaging is not permitted. Where practical, a sample detection and single sweep mode shall be used. Otherwise, peak detection and max-hold mode (until the trace stabilizes) shall be used. f) Use the 99% power bandwidth function of the instrument (if available) and report the measured bandwidth. g) If the instrument does not have a 99% power bandwidth function,
Microtest	then the trace data points are recovered and directly summed in linear power terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached; that frequency is recorded as the lower frequency. The process is repeated until 99.5% of the total is reached; that frequency is recorded as the upper frequency. The 99% power bandwidth is the difference between these two frequencies. h) The occupied bandwidth shall be reported by providing spectral plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).

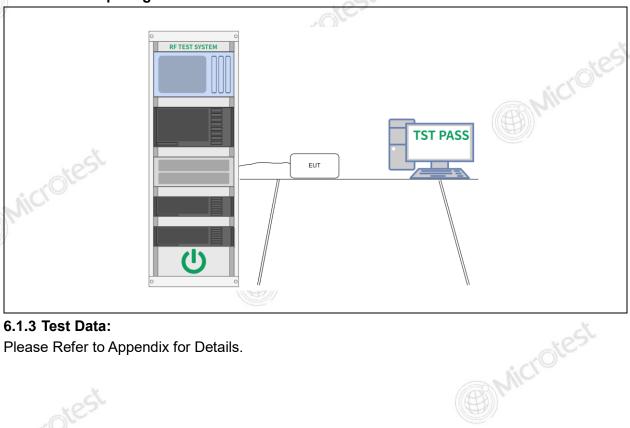


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6.1.1 E.U.T. Operation:

Operating Envi	ironme	nt:			
Temperature: 24.6 °C		,C	Humidity:	55 %	Atmospheric Pressure: 101 kPa
Pre test mode: Mode1, Mode2, Mo		Mode3			
Final test mode: Mode1, Mode2, Mode3					

6.1.2 Test Setup Diagram:



6.1.3 Test Data:

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Please Refer to Appendix for Details.



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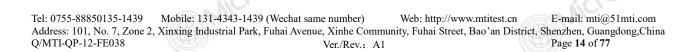
6.2 Maximum Conducted Output Power

O.Z Waxiiilaiii Oone	•	
Test Requirement:	47 CFR 15.247(b)(1)	
Test Limit:	Refer to 47 CFR 15.247(b)(1), For free operating in the 2400-2483.5 MHz bare overlapping hopping channels, and all the 5725-5850 MHz band: 1 watt. For systems in the 2400-2483.5 MHz band	nd employing at least 75 non- I frequency hopping systems in all other frequency hopping
Test Method:	ANSI C63.10-2020, section 7.8.5 KDB 558074 D01 15.247 Meas Guida	ance v05r02
Procedure:	This is an RF-conducted test to evaluate Use a direct connection between the awireless device and the spectrum and attenuation. Frequency hopping shall following spectrum analyzer settings: a) Span: Approximately five times the hopping channel. b) RBW > 20 dB bandwidth of the emic) VBW ≥ RBW. d) Sweep: No faster than coupled (aure) Detector function: Peak. f) Trace: Max-hold. g) Allow trace to stabilize. h) Use the marker-to-peak function to emission. i) The indicated level is the peak output for external attenuators and cables. j) A spectral plot of the test results and included in the test report. NOTE—A peak responding power me power meter and sensor system video occupied bandwidth of the unlicensed spectrum analyzer.	antenna port of the unlicensed alyzer, through suitable be disabled for this test. Use the 20 dB bandwidth, centered on a ission being measured. to) time. set the marker to the peak of the ut power, after any corrections d setup description shall be eter may be used, where the bandwidth is greater than the

6.2.1 E.U.T. Operation:

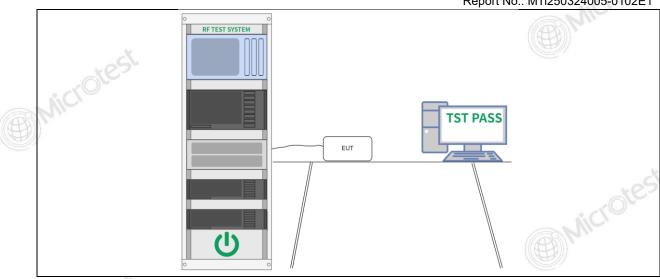
Operating Environment:								
Temperature: 24.6 °C Humidity: 55 % Atmospheric Pressure: 101 kPa					101 kPa			
Pre test mode: Mode1,			e1, Mode2,	Mode3				
Final test mode: M		Mod	e1, Mode2,	Mode3		Ž.		

6.2.2 Test Setup Diagram:





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6.2.3 Test Data:

Please Refer to Appendix for Details.





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6.3 Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Limit:	Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	ANSI C63.10-2020, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A spectral plot of the

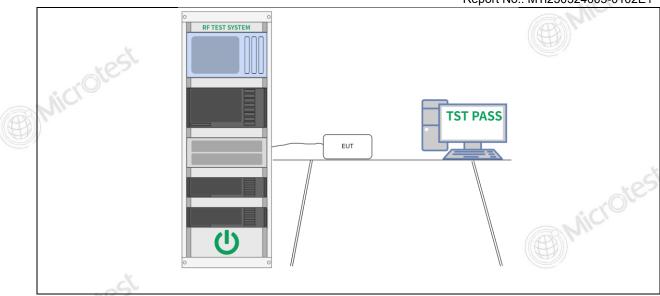
6.3.1 E.U.T. Operation:

Operating Environment:							
Temperature:	Humidity:	55 %		Atmospheric Pressure:	101 kPa		
Pre test mode: Mode1, Mode2, Mode3							
Final test mode: Mode1, Mode2, Mode3				X			

6.3.2 Test Setup Diagram:



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6.3.3 Test Data:

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Please Refer to Appendix for Details.

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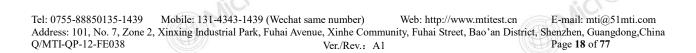
6.4 Number of Hopping Frequencies

•		
Test Requirement:	47 CFR 15.247(a)(1)(iii)	
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fer 2400-2483.5 MHz band shall use at time of occupancy on any channel sh seconds within a period of 0.4 secon hopping channels employed. Freque or suppress transmissions on a particular that a minimum of 15 channels are u	least 15 channels. The average hall not be greater than 0.4 ds multiplied by the number of ency hopping systems may avoid cular hopping frequency provided
Test Method:	ANSI C63.10-2020, section 7.8.3 KDB 558074 D01 15.247 Meas Guid	lance v05r02
Procedure:	The EUT shall have its hopping function spectrum analyzer settings: a) Span: The frequency band of oper of channels the device supports, it confrequency range of operation across individual channels to be clearly seen b) RBW: To identify clearly the individues than 30% of the channel spacing whichever is smaller. c) VBW ≥ RBW. d) Sweep: No faster than coupled (at e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize.	ration. Depending on the number buld be necessary to divide the multiple spans, to allow the n. dual channels, set the RBW to g or the 20 dB bandwidth,
otest.	It might prove necessary to break the clearly all of the hopping frequencies appropriate regulatory limit shall be chopping channels. A spectral plot of t test report.	c. Compliance of an EUT with the determined for the number of

6.4.1 E.U.T. Operation:

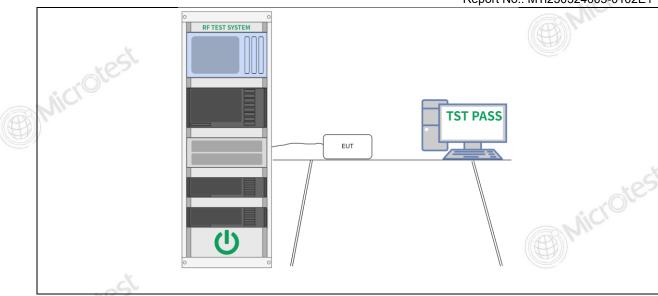
Operating Environment:								
Temperature: 24.6 °C Humidity: 55 % Atmospheric Pressure: 101 kPa								
Pre test mode: Mode1, Mode2, Mode3								
Final test mode: Mode1, Mode2, Mode3								

6.4.2 Test Setup Diagram:





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6.4.3 Test Data:

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Please Refer to Appendix for Details.

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6.5 Dwell Time

6.5 Dwell Time	
Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2020, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The dwell time per hop on a channel is the time from the start of the first transmission to the end of the last transmission for that hop. If the device has a single transmission per hop then the dwell time is the duration of that transmission. If the device has a multiple transmissions per hop then the dwell time is measured from the start of the first transmission to the end of the last transmission.
Mic	The time of occupancy is the total time that the device dwells on a channel over an observation period specified in the regulatory requirement. To determine the time of occupancy the spectrum analyzer will be configured to measure both the dwell time per hop and the number of times the device transmits on a specific channel in a given period.
Microtest	The EUT shall have its hopping function enabled. Compliance with the requirements shall be made with the minimum and with the maximum number of channels enabled. If the dwell time per channel does not vary with the number of channels than compliance with the requirements may be based on the minimum number of channels. If the device supports different dwell times per channel (example Bluetooth devices can dwell on a channel for 1, 3 or 5 time slots) then measurements can be limited to the longest dwell time with the minimum number of channels.
	Use the following spectrum analyzer settings to determine the dwell time per hop:
Microtest	 a) Span: Zero span, centered on a hopping channel. b) RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the expected transmission time per hop. c) Sweep time: Set so that the start of the first transmission and end of the last transmission for the hop are clearly captured. Setting the sweep time to be slightly longer than the hopping period per channel (hopping period = 1/hopping rate) should achieve this. d) Use a video trigger, where possible with a trigger delay, so that the start of the transmission is clearly observed. The trigger level might need adjustment to reduce the chance of triggering when the system hops on an adjacent channel. e) Detector function: Peak. f) Trace: Clear-write, single sweep. g) Place markers at the start of the first transmission on the channel



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and at the end of the last transmission. The dwell time per hop is the time between these two markers.

To determine the number of hops on a channel in the regulatory observation period repeat the measurement using a longer sweep time. When the device uses a single hopping sequence the period of measurement should be sufficient to capture at least 2 hops. When the device uses a dynamic hopping sequence, or the sequence varies, the period of measurement may need to capture multiple hops to better determine the average time of occupancy. Count the number of hops on the channel across the sweep time.

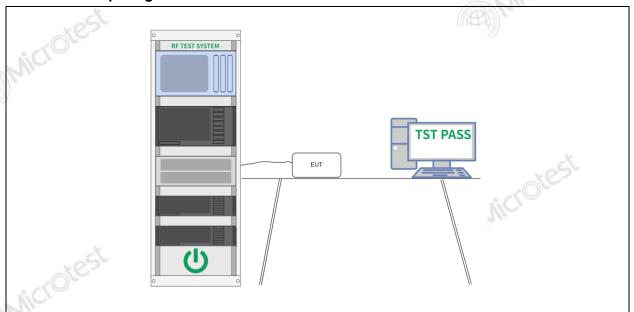
The average number of hops on the same channel within the regulatory observation period is calculated from the number of hops on the channel divided by the spectrum analyzer sweep time multiplied by the regulatory observation period. For example, if three hops are counted with an analyzer sweep time of 500 ms and the regulatory observation period is 10 s, then the number of hops in that ten seconds is $3 / 0.5 \times 10$, or 60 hops.

The average time of occupancy is calculated by multiplying the dwell time per hop by the number of hops in the observation period.

6.5.1 E.U.T. Operation:

Operating Environment:									
Temperature:	emperature: 24.6 °		Humidity:	55 %		Atmospheric Pressure:	101 kPa		
Pre test mode:	Mod	e1, Mode2, I	Mode3			25%			
Final test mode	Mod	e1, Mode2, I	Mode3			· Ster			

6.5.2 Test Setup Diagram:



6.5.3 Test Data:

Please Refer to Appendix for Details.



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6.6 RF conducted spurious emissions and band edge measurement

Test Requirement:	47 CFR 15.247(d), 15.209, 15.205
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	ANSI C63.10-2020 section 7.8.7 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	7.8.7.1 General considerations To demonstrate compliance with the relative out-of-band emissions requirements conducted spurious emissions shall be measured for the transmit frequencies, per 5.5 and 5.6, and at the maximum transmit powers. Frequency hopping shall be disabled for this test with the exception of measurements at the allocated band-edges which shall be repeated with hopping enabled.
Microtest	Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The frequency range of testing shall span 30 MHz to 10 times the operating frequency and this may be done in a single sweep or, to aid resolution, across a number of sweeps. The resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector.
	The limit is based on the highest in-band level across all channels measured using the same instrument settings (resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector). To help clearly demonstrate compliance a display line may be set at the required offset (typically 20 dB) below the highest in-band level. Where the highest in-band level is not clearly identified in the out-of-band measurements a separate spectral plot showing the in-band level shall be provided.
Microtest	When conducted measurements cannot be made (for example a device with integrated, non-removable antenna) radiated measurements shall be used. The reference level for determining the limit shall be established by maximizing the field strength from the highest power channel and measuring using the resolution and video bandwidth settings and peak detector as described above. The field strength limit for spurious emissions outside of restricted-bands shall then be set at the required offset (typically 20 dB) below the highest inband level. Radiated measurements will follow the standards



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measurement procedures described in Clause 6 with the exception that the resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector. Note that use of wider measurement bandwidths are acceptable for measuring the spurious emissions provided that the peak detector is used and that the measured value of spurious emissions are compared to the highest in-band level measured with the 100 kHz / 300 kHz bandwidth settings to determine compliance.

7.8.7.2 Band-edges

Compliance with a relative limit at the band-edges (e.g., -20 dBc) shall be made on the lowest and on the highest channels with frequency hopping disabled and repeated with frequency hopping enabled. For the latter test the hopping sequence shall include the lowest and highest channels.

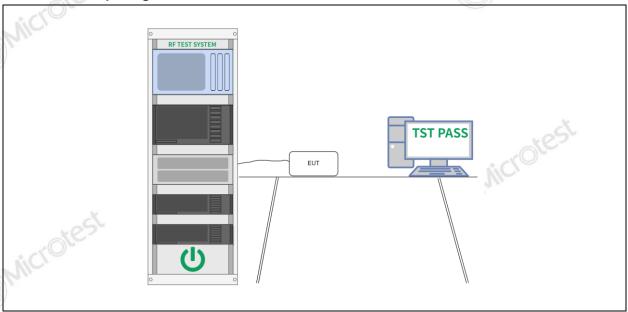
For measurements with the hopping disabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of the allocated band-edge.

For measurements with the hopping enabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of both of the allocated band-edges. This could require separate spectral plots for each band-edge.

6.6.1 E.U.T. Operation:

Operating Environment:									
Temperature: 24.6 °		С	Humidity:	55 %		Atmospheric Pressure:	101 kPa		
Pre test mode:		Mod	e1, Mode2,	Mode3			i Clo		
Final test mode	Mode1, Mode2, Mode3								

6.6.2 Test Setup Diagram:



6.6.3 Test Data:

Please Refer to Appendix for Details.



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6.7 Band edge emissions (Radiated)

Test Requirement:	15.205(c)).`						
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
	Above 960	500	3				
Microtest	** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.						
Test Method:	ANSI C63.10-2020 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02						
Procedure:	ANSI C63.10-2020 sed	etion 6.10.5.2	A.				

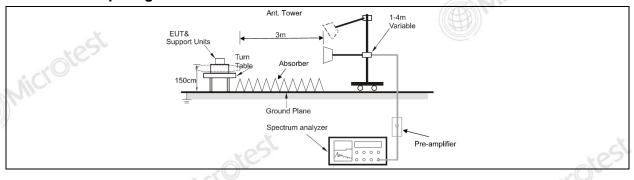
6.7.1 E.U.T. Operation:

	-4"								
	Operating Environment:								
3	Temperature: 19.6 °C		,C	Humidity: 45.4 % Atmospheric Pres		Atmospheric Pressure:	98 kPa		
	Pre test mode:		Mode1, Mode2, Mode3						
	Final test mode	e:	All of the listed pre-test mode were tested, only the data of the worst mode (Mode3) is recorded in the report						
	NI-4		•			•			

Note

The amplitude of spurious emissions which are attenuated more than 20 dB below the limits are not reported.

6.7.2 Test Setup Diagram:





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6.7.3 Test Data:

								11/1/13	26.717.00		
Mod	Mode3 / Polarization: Horizontal / CH: L Reading Correct Measure- No. Mk. Freq. Level Factor ment Limit Over										
	No.	Mk.	Freq.	-			Limit	Over			
NI			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector		
	1		2310.000	47.81	-4.83	42.98	74.00	-31.02	peak		
	2		2310.000	38.03	-4.83	33.20	54.00	-20.80	AVG	-	
	3		2390.000	48.24	-4.31	43.93	74.00	-30.07	peak	e5)	
	4	*	2390.000	38.20	-4.31	33.89	54.00	-20.11	AVG	_	

No.			Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		2310.000	47.99	-4.83	43.16	74.00	-30.84	peak
2		2310.000	38.12	-4.83	33.29	54.00	-20.71	AVG
3		2390.000	47.19	-4.31	42.88	74.00	-31.12	peak
4	*	2390.000	38.23	-4.31	33.92	54.00	-20.08	AVG



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Mod	e3 / P	olari	zation: Hori	zontal / CH:	Н						
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	24.111		
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector		
PVI.	1		2483.500	55.38	-4.21	51.17	74.00	-22.83	peak		
1	2	*	2483.500	38.41	-4.21	34.20	54.00	-19.80	AVG		
'	3		2500.000	49.44	-4.10	45.34	74.00	-28.66	peak		
,	4		2500.000	38.05	-4.10	33.95	54.00	-20.05	AVG	-Se	
1											

Mode3 / Polarization: Vertical / CH: H									
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		2483.500	51.00	-4.21	46.79	74.00	-27.21	peak
	2		2483.500	38.14	-4.21	33.93	54.00	-20.07	AVG
	3		2500.000	48.44	-4.10	44.34	74.00	-29.66	peak
	4	*	2500.000	38.16	-4.10	34.06	54.00	-19.94	AVG



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6.8 Radiated emissions (below 1GHz)

Test Requirement:	Refer to 47 CFR 15.247(d), In addition, radiated emissions which in the restricted bands, as defined in § 15.205(a), must also comp with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).`						
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
	Above 960	500	3				
Microtest	intentional radiators ope the frequency bands 52 806 MHz. However, op- permitted under other s In the emission table at The emission limits sho measurements employ frequency bands 9–90 Radiated emission limit	n paragraph (g), fundamental erating under this section shad-72 MHz, 76-88 MHz, 174-2 eration within these frequence ections of this part, e.g., §§ 100ve, the tighter limit applies own in the above table are bang a CISPR quasi-peak detector.	all not be located in 16 MHz or 470- y bands is 15.231 and 15.241. at the band edges. sed on ector except for the e 1000 MHz.				
Test Method:	ANSI C63.10-2020 section 6.6.4 KDB 558074 D01 15.247 Meas Guidance v05r02						
Procedure:	ANSI C63.10-2020 sec	tion 6.6.4	la.				

6.8.1 E.U.T. Operation:

	Operating Environment:								
3	Temperature: 19.6 °C		,C	Humidity:	lity: 45.4 % Atmospheric Pressur		98 kPa		
	Pre test mode:		Mode1, Mode2, Mode3						
	Final test mode	e:	All of the listed pre-test mode were tested, only the data of the worst mode (Mode3) is recorded in the report						
ŀ				(1111 111 1)					

Note

The amplitude of spurious emissions which are attenuated more than 20 dB below the limits are not reported.

All modes of operation of the EUT were investigated, and only the worst-case results are reported. There were no emissions found below 30MHz within 20dB of the limit.

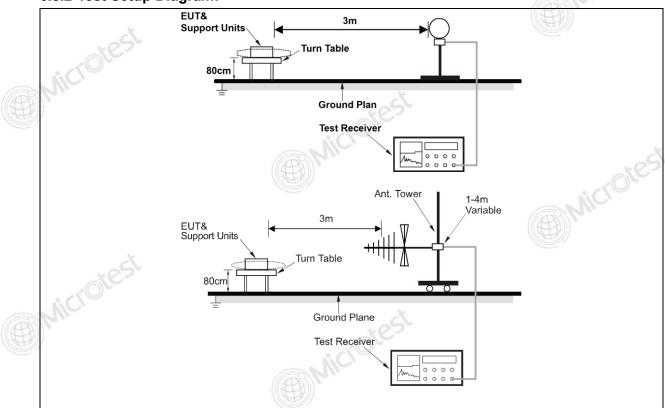


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6.8.2 Test Setup Diagram:

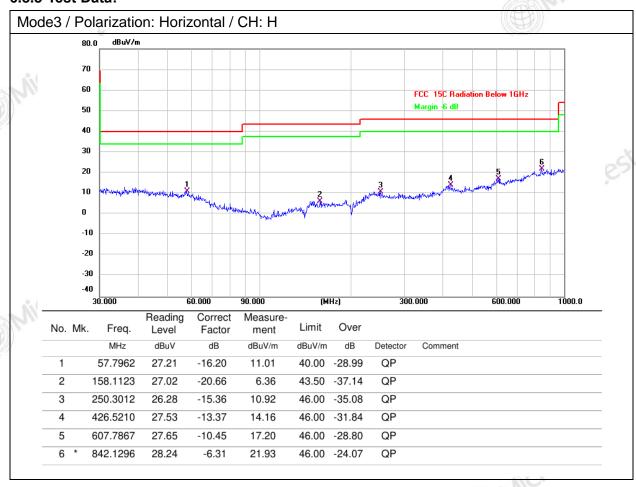




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6.8.3 Test Data:

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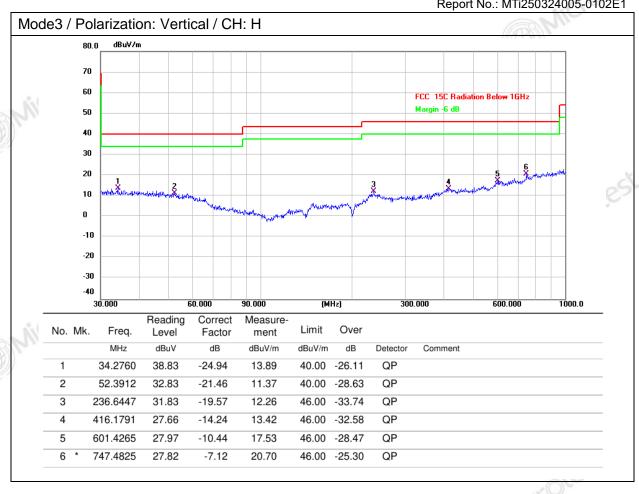




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6.9 Radiated emissions (above 1GHz)

Test Requirement:	defined in § 15.205(a),	nissions which fall in the restricted must also comply with the radia 209(a)(see § 15.205(c)).`	
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
Microtest	intentional radiators op the frequency bands 54 806 MHz. However, op permitted under other s In the emission table al The emission limits sho measurements employ frequency bands 9–90 Radiated emission limit	n paragraph (g), fundamental enerating under this section shall nd 1-72 MHz, 76-88 MHz, 174-216 becation within these frequency becations of this part, e.g., §§ 15.2 bove, the tighter limit applies at the town in the above table are baseding a CISPR quasi-peak detector kHz, 110–490 kHz and above 10 is in these three bands are baseding an average detector.	not be located in MHz or 470- ands is 231 and 15.241. he band edges. d on rexcept for the 1000 MHz.
Test Method:	ANSI C63.10-2020 sec KDB 558074 D01 15.24	tion 6.6.4 47 Meas Guidance v05r02	test
Procedure:	ANSI C63.10-2020 sec	tion 6.6.4	CI

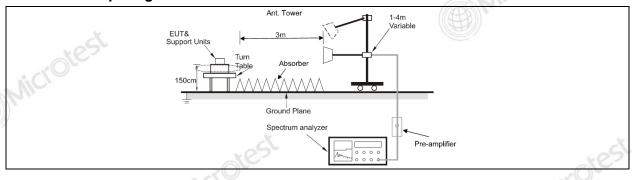
6.9.1 E.U.T. Operation:

Operating Envi	ronme	nt:				
Temperature: 19.6 °		,C	Humidity:	45.4 %	Atmospheric Pressure:	98 kPa
Pre test mode:	Mod	e1, Mode2,	Mode3			
Final test mode:			f the listed p e (Mode3) is		e were tested, only the dat the report	a of the worst

Note: Test frequency are from 1GHz to 25GHz, the amplitude of spurious emissions which are attenuated more than 20 dB below the limits are not reported.

All modes of operation of the EUT were investigated, and only the worst-case results are reported.

6.9.2 Test Setup Diagram:





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6.9.3 Test Data:

Mod	e3 / P	olari	zation: Horiz	zontal / CH:	L				3)))	
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
NI.			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	
	1		4804.000	53.66	0.53	54.19	74.00	-19.81	peak	
	2		4804.000	48.71	0.53	49.24	54.00	-4.76	AVG	_
	3		7206.000	43.43	7.90	51.33	74.00	-22.67	peak	-e5
	4		7206.000	38.42	7.90	46.32	54.00	-7.68	AVG	
	5		9608.000	49.32	8.85	58.17	74.00	-15.83	peak	
	6	*	9608.000	41.90	8.85	50.75	54.00	-3.25	AVG	
										_

/lode	e3 / Po	olariz	zation: Verti	6	MICI.				
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		4804.000	53.16	0.53	53.69	74.00	-20.31	peak
	2		4804.000	49.10	0.53	49.63	54.00	-4.37	AVG
	3		7206.000	42.93	7.90	50.83	74.00	-23.17	peak
201	4		7206.000	37.92	7.90	45.82	54.00	-8.18	AVG
W-	5		9608.000	48.82	8.85	57.67	74.00	-16.33	peak
	6	*	9608.000	41.61	8.85	50.46	54.00	-3.54	AVG



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									0.40	-
Mod	e3 / P	olari	zation: Horiz							
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	O III	
2.1			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	
M	1		4882.000	53.01	0.57	53.58	74.00	-20.42	peak	
)	2		4882.000	46.66	0.57	47.23	54.00	-6.77	AVG	_
	3		7323.000	43.38	7.57	50.95	74.00	-23.05	peak	<
	4		7323.000	37.69	7.57	45.26	54.00	-8.74	AVG	62
	5		9764.000	48.54	9.33	57.87	74.00	-16.13	peak	
	6	*	9764.000	40.96	9.33	50.29	54.00	-3.71	AVG	

Mod	e3 / P	olariz	zation: Verti	cal / CH: M	200				
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		4882.000	43.35	0.57	43.92	74.00	-30.08	peak
	2		4882.000	38.75	0.57	39.32	54.00	-14.68	AVG
	3		7323.000	43.41	7.57	50.98	74.00	-23.02	peak
	4		7323.000	37.64	7.57	45.21	54.00	-8.79	AVG
'i'A	5		9764.000	46.64	9.33	55.97	74.00	-18.03	peak
14.	6	*	9764.000	40.79	9.33	50.12	54.00	-3.88	AVG



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Mod	e3 / P	olari	zation: Horiz	zontal / CH:	Н			(a)	BUILD	
	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	24.111	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	
MI	1		4960.000	55.09	0.66	55.75	74.00	-18.25	peak	
,	2		4960.000	49.55	0.66	50.21	54.00	-3.79	AVG	
	3		7440.000	43.65	7.94	51.59	74.00	-22.41	peak	_ <
	4		7440.000	38.38	7.94	46.32	54.00	-7.68	AVG	62
	5		9920.000	47.52	9.69	57.21	74.00	-16.79	peak	
	6	*	9920.000	40.54	9.69	50.23	54.00	-3.77	AVG	

	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		4960.000	50.59	0.66	51.25	74.00	-22.75	peak
	2		4960.000	44.57	0.66	45.23	54.00	-8.77	AVG
	3		7440.000	42.65	7.94	50.59	74.00	-23.41	peak
	4		7440.000	38.27	7.94	46.21	54.00	-7.79	AVG
į	5		9920.000	47.02	9.69	56.71	74.00	-17.29	peak
	6	*	9920.000	39.54	9.69	49.23	54.00	-4.77	AVG



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Photographs of the test setup

Refer to Appendix - Test Setup Photos













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Photographs of the EUT

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Appendix A: 20dB Emission Bandwidth

Appendix A: 20	dB Emission	Bandwidth	i s
Test Result			: crottes
Test Mode	Antenna	Frequency [MHz]	20db EBW [MHz]
are-		2402	0.954
DH5	Ant1	2441	0.942
VIC.		2480	0.876
La.		2402	1.230
2DH5	Ant1	2441	1.314
2)		2480	1.221
		2402	1.257
3DH5	Ant1	2441	1.212
		2480	1.311



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Test Graphs





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